

ID	R _{Ds} (ON)(Typ)	VDSS
13A	0.39Ω	500V

Applications:

- Switch Mode Power Supply(SMPS)
- Uninterruptible Power Supply (UPS)
- Power Factor Correction (PFC)

Features:

- Fast switching speed
- 100% avalanche tested
- Improved dv/dt capability

$\mathbf{F}_{\mathsf{COHS}}$

Ordering Information

Part Number	Package	Marking	Packing	Qty.
RS13N50F	T0-220F	RS13N50F	Tube	50 PCS

Absolute Maximun Ratings Tc= 25° C unless otherwise specified

Symbol	Parameter	RS13N50F	Units
VDSS	Drain-to-Source Voltage	500	V
ID	Continuous Drain Current TC=25℃	13	۸
IDM	Pulsed Drain Current (Note*1)	52	A
PD	Power Dissipation	49	W
VGS	Gate- to- Source Voltage	±30	V
EAS	Single Pulse Avalanche Engergy L = 10mH, VDD = 50V, RG = 25 Ω	352	mJ
	Maximum Temperature for Soldering		
TL TPKG	Leads at 0.063in(1.6mm)from Case for 10 seconds Package Body for 10 seconds	300 260	°C
TJ and TSTG	Operating Junction and Storage Temperature Range	-55 to 150	

* Drain Current Limited by Maximum Junction Temperature

Caution: Stresses greater than those listed in the" Absolute Maximum Ratings" Table may cause permanent damage to the device.



Thermal Resistance

Symbol	Parameter	RS13N50F	Units	Test Conditions
RØJC	Junction-to-Case	2.55	°C/W	Drain lead soldered to water cooled heatsink, PD adjusted for a peak junction temperature of + 1 5 0 $^\circ\!\!\mathbb{C}$
RθJA	Junction-to- Ambient	62.5		1 cubic foot chamber,free air.

OFF Characteristics TJ= 25° C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
BVDSS	Drain- to- source Breakdown Voltage	500			V	VGS=0V,ID=250μ Α
IDSS	Drain- to- Source Leakage Current			1	μA	VDS=500V,VGS= 0V
	Gate- to- Source Forward Leakage			100	~ ^	VGS=30V ,VDS=0 V
IGSS	Gate- to- Source Reverse Leakage			-100	nA	VGS=-30V ,VDS= 0V

ON Characteristics TJ=25°C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
RDS(on)	Static Drain- to- Source On- Resistance(Note*2)		0.39	0.46	Ω	VGS=10V,ID=6.5 A
VGS(TH)	Gate Threshold Voltage	3		4	V	VGS=VDS,ID=25 0μA

Resistive Switching Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
td(ON)	Turn- on Delay Time		43.2			
trise	Rise Time		24.8			VDS=250V
td(OFF)	Turn- OFF Delay Time		131. 8		nS	ID=13A RG=25Ω
tfall	Fall Time		42.6			



Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
Ciss	Input Capacitance		1569			VGS=0V
Coss	Output Capacitance		171		pF	VDS=25V f=1.0MHz
Crss	Reverse Transfer Capacitance		5			
Qg	Total Gate Charge		30.9			VDS=400V
Qgs	Gate- to- Source Charge		7.8		nC	ID=13A VGS=10V
Qgd	Gate-to-Drain(" Miller") Charge		10.6			

Dynamic Characteristics Essentially independent of operating temperature

Source- Drain Diode Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
IS	Continuous Source Current			13	А	Integral pn- diode
ISM	Maximum Pulsed Current			52	А	in MOSFET
VSD	Diode Forward Voltage			1.4	V	IS=6.5A,VGS=0V
trr	Reverse Recovery Time		307		nS	VGS=0V
Qrr	Reverse Recovery Charge		3.5		μC	IS=13A,di/dt=100 A/µs

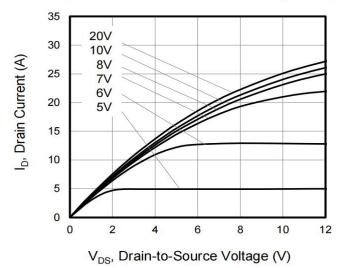
Notes:

- * 1. Repetitive rating, pulse width limited by maximum junction temperature.
- * 2. Pulse Test: Pulse width \leq 300µs, Duty Cycle \leq 1%

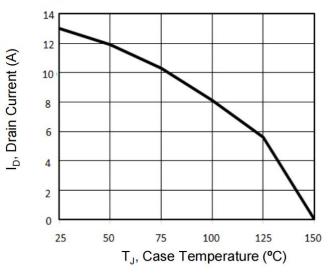


Typical Feature Curve

Figure 1. Output Characteristics (T_J = 25°C)







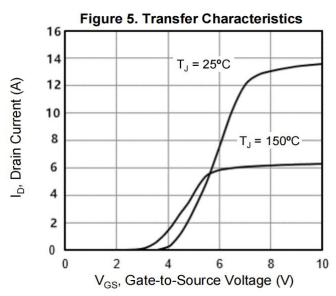


Figure 2. Body Diode Forward Voltage

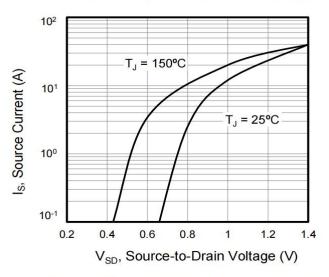


Figure 4. BV_{DSS} Variation vs. Temperature

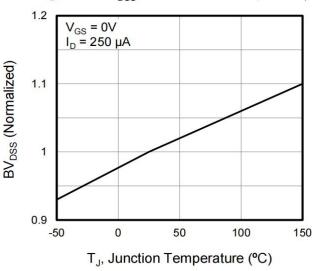
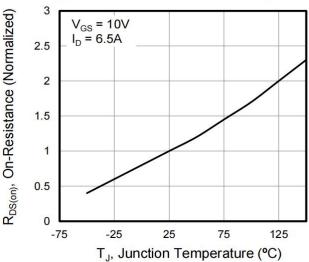


Figure 6. On-Resistance vs. Temperature





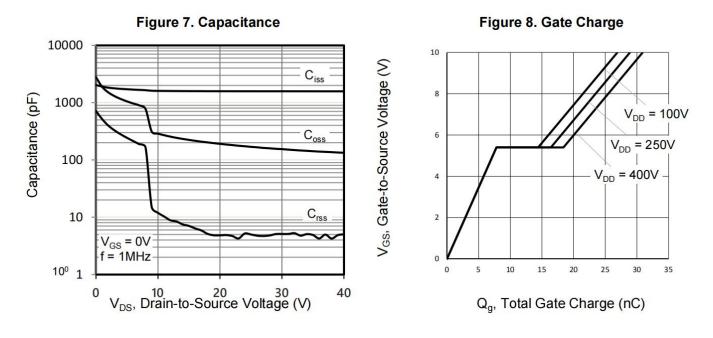
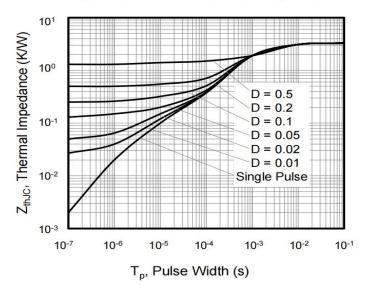


Figure 9. Transient Thermal Impedance





Test Circuits and Waveforms

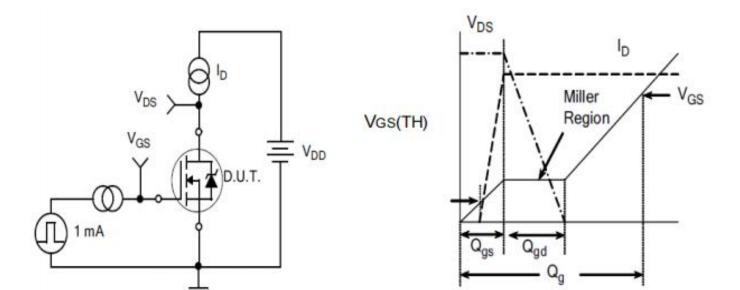
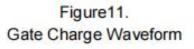


Figure10. Gate Charge Test Circuit



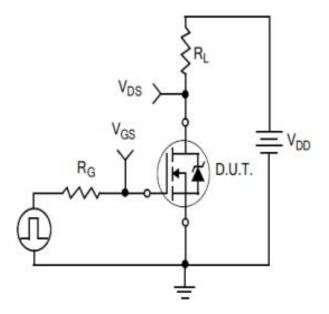


Figure12. Resistive Switching Test Circuit

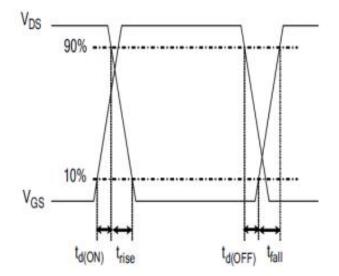


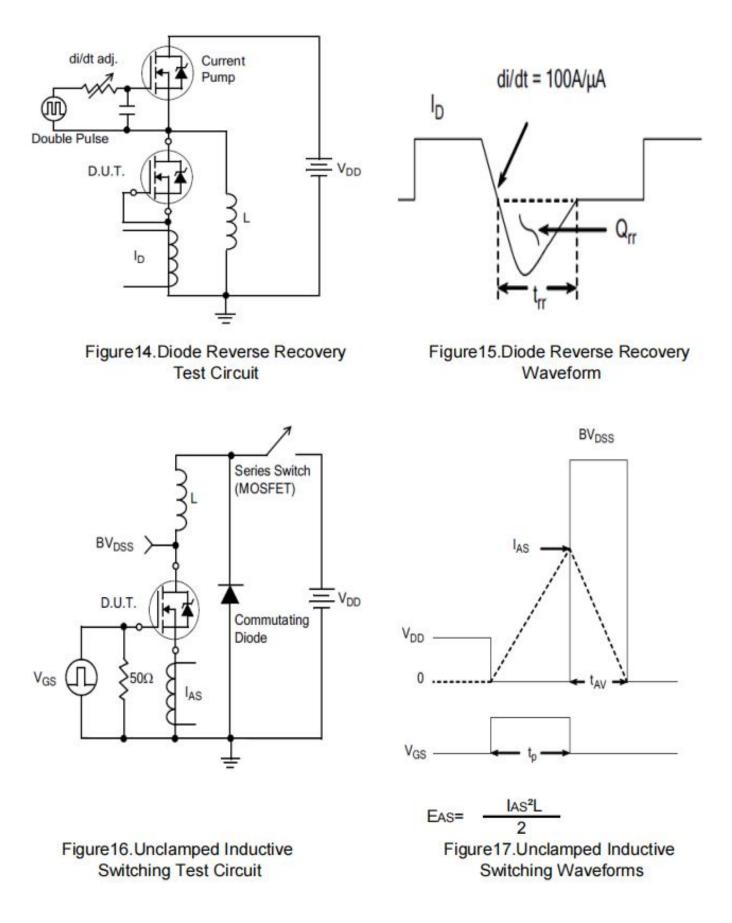
Figure13. Resistive Switching Waveforms

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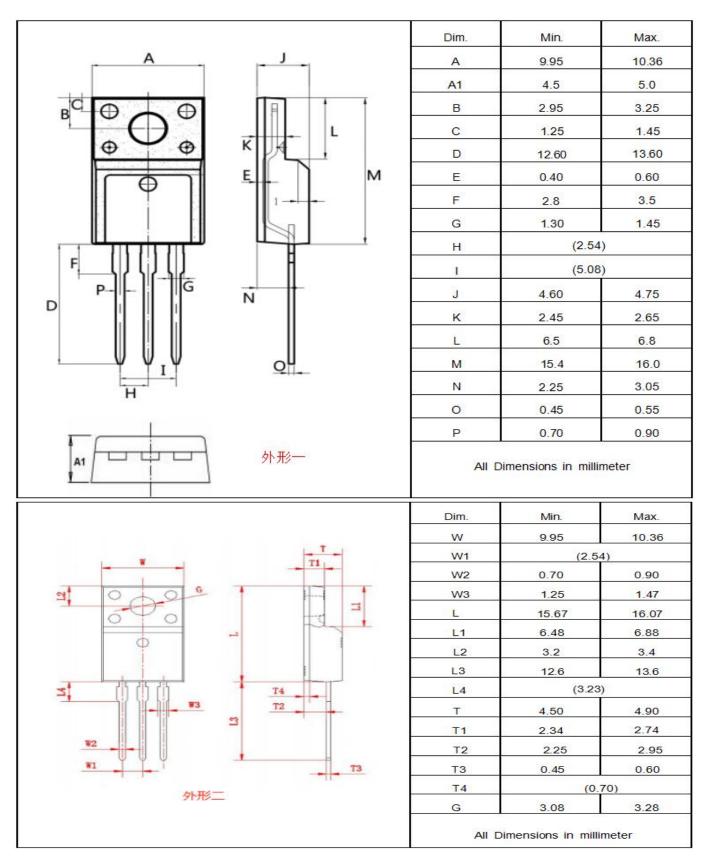


Test Circuits and Waveforms





Package outline drawing(TO-220F Unit: mm)





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